N-channel TrenchMOS logic level FET Rev. 03 — 22 February 2008

Product data sheet

Product profile 1.

1.1 General description

Logic level N-channel enhancement mode Field-Effect Transistor (FET) in a plastic package using NXP High-Performance Automotive (HPA) TrenchMOS technology. This product has been designed and qualified to the appropriate AEC standard for use in automotive critical applications.

1.2 Features

- 175 °C rated
- Q101 compliant

1.3 Applications

- 12 V and 24 V loads
- General purpose power switching
- Logic level compatible
- Very low on-state resistance
- Automotive systems
- Motors, lamps and solenoids

1.4 Quick reference data

Table 1. Quick reference

Quick reference					
Parameter	Conditions	Min	Тур	Max	Unit
drain current	$V_{GS} = 5 \text{ V}; T_{mb} = 25 \text{ °C};$ see <u>Figure 1</u> and <u>4</u>	-	-	26	A
total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	-	59	W
aracteristics					
drain-source on-state resistance	$V_{GS} = 5 \text{ V}; I_D = 15 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } \frac{\text{Figure } 12}{13} \text{ and } \frac{13}{13}$	-	34	40	mΩ
he ruggedness					
non-repetitive drain-source avalanche energy	$ \begin{split} I_D &= 26 \text{ A}; V_{sup} \leq 55 \text{ V}; \\ R_{GS} &= 50 \Omega; V_{GS} = 5 \text{ V}; \\ T_{j(init)} &= 25 ^\circ\text{C}; \text{unclamped} \end{split} $	-	-	36	mJ
	Parameter drain current total power dissipation aracteristics drain-source on-state resistance neruggedness non-repetitive drain-source avalanche	ParameterConditionsdrain current $V_{GS} = 5 \text{ V}; T_{mb} = 25 \text{ °C};$ see Figure 1 and 4total power dissipation $T_{mb} = 25 \text{ °C};$ see Figure 2aracteristicsdrain-source on-state resistance $V_{GS} = 5 \text{ V}; I_D = 15 \text{ A};$ $T_j = 25 \text{ °C};$ see Figure 12 and 13non-repetitive drain-source avalanche $I_D = 26 \text{ A}; V_{sup} \le 55 \text{ V};$ $R_{GS} = 50 \Omega; V_{GS} = 5 \text{ V};$	$\begin{array}{ c c c } \hline \textbf{Parameter} & \textbf{Conditions} & \textbf{Min} \\ \hline drain current & V_{GS} = 5 \ V; \ T_{mb} = 25 \ ^{\circ}\text{C}; & - & \\ & see \ \overline{Figure \ 1} \ and \ \underline{4} & \\ \hline total power dissipation & T_{mb} = 25 \ ^{\circ}\text{C}; \ see \ \overline{Figure \ 2} & - & \\ \hline \textbf{aracteristics} & & \\ \hline \textbf{drain-source on-state} & V_{GS} = 5 \ V; \ I_D = 15 \ \text{A}; & \\ T_j = 25 \ ^{\circ}\text{C}; \ see \ \overline{Figure \ 12} \ and & \\ \hline \textbf{13} & & \\ \hline \textbf{non-repetitive} & I_D = 26 \ \text{A}; \ V_{sup} \le 55 \ V; & \\ \hline \textbf{R}_{GS} = 50 \ \Omega; \ V_{GS} = 5 \ V; & \\ \hline \textbf{Conditions} & & \\ \hline \textbf{Conditions} & & \\ \hline \textbf{Conditions} & & \\ \hline \textbf{Min} & & \\ \hline \textbf{Min} & & \\ \hline \textbf{Min} & & \\ \hline \textbf{Conditions} & & \\ \hline \textbf{Min} & & \\ \hline \textbf{Min} & & \\ \hline \textbf{Conditions} & & \\ \hline \textbf{Min} & & \\ \hline$	ParameterConditionsMinTypdrain current $V_{GS} = 5 \text{ V}; T_{mb} = 25 \text{ °C};$ see Figure 1 and 4total power dissipation $T_{mb} = 25 \text{ °C};$ see Figure 2aracteristics $T_{mb} = 25 \text{ °C};$ see Figure 2drain-source on-state resistance $V_{GS} = 5 \text{ V}; I_D = 15 \text{ A};$ $T_j = 25 \text{ °C};$ see Figure 12 and 13 -34non-repetitive drain-source avalanche $I_D = 26 \text{ A}; V_{sup} \le 55 \text{ V};$ $R_{GS} = 50 \Omega; V_{GS} = 5 \text{ V};$	ParameterConditionsMinTypMaxdrain current $V_{GS} = 5 V; T_{mb} = 25 °C;$ see Figure 1 and 426total power dissipation $T_{mb} = 25 °C;$ see Figure 259aracteristics-59drain-source on-state resistance $V_{GS} = 5 V; I_D = 15 A;$ $T_j = 25 °C;$ see Figure 12 and



2. Pinning information

Table 2.	Pinning			
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source	mb	D
2	S	source		$\overset{\circ}{\frown}$
3	S	source		
4	G	gate	σ	
mb	D	mounting base; connected to drain	Ŭ Ū Ū Ŭ 1 2 3 4 SOT669 (LFPAK)	mbb076 S

3. Ordering information

Table 3.Ordering information

Type number	Package	Package			
	Name	Description	Version		
BUK9Y40-55B	LFPAK	plastic single-ended surface-mounted package (LFPAK); 4 leads	SOT669		

4. Limiting values

Table 4.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	$T_j \ge 25 \text{ °C}; T_j \le 175 \text{ °C}$	-	55	V
V _{DGR}	drain-gate voltage	R _{GS} = 20 kΩ	-	55	V
V _{GS}	gate-source voltage		-15	15	V
I _D	drain current	T_{mb} = 100 °C; V_{GS} = 5 V; see <u>Figure 1</u>	-	18	А
		T_{mb} = 25 °C; V_{GS} = 5 V; see <u>Figure 1</u> and <u>4</u>	-	26	А
I _{DM}	peak drain current	T_{mb} = 25 °C; $t_p \leq$ 10 $\mu s;$ pulsed; see Figure 4	-	106	А
P _{tot}	total power dissipation	T _{mb} = 25 °C; see <u>Figure 2</u>	-	59	W
T _{stg}	storage temperature		-55	175	°C
Tj	junction temperature		-55	175	°C
Avalancl	he ruggedness				
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	$\label{eq:ld} \begin{array}{l} I_D = 26 \text{ A}; \ V_{sup} \leq 55 \text{ V}; \ R_{GS} = 50 \ \Omega; \ V_{GS} = 5 \text{ V}; \\ T_{j(init)} = 25 \ ^{\circ}C; \ unclamped \end{array}$	-	36	mJ
E _{DS(AL)R}	repetitive drain-source avalanche energy	see Figure 3	[1][2] [3]	-	J
Source-o	drain diode				
I _S	source current	T _{mb} = 25 °C	-	26	А
I _{SM}	peak source current	$t_p \leq$ 10 µs; pulsed; T_{mb} = 25 °C	-	106	А

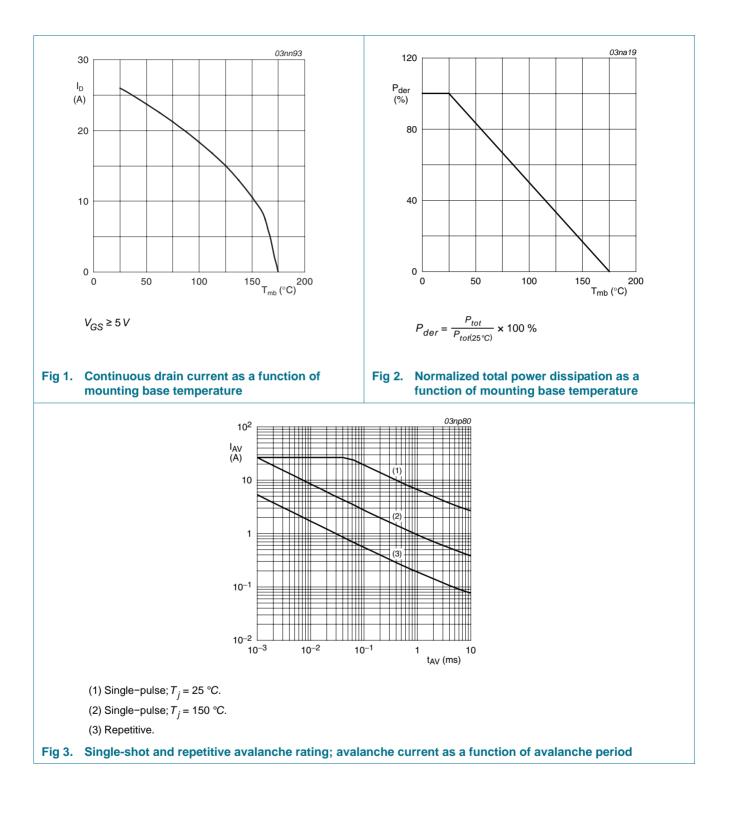
[1] Single-pulse avalanche rating limited by maximum junction temperature of 175 $^\circ$ C.

[2] Repetitive avalanche rating limited by average junction temperature of 170 °C.

[3] Refer to application note AN10273 for further information.

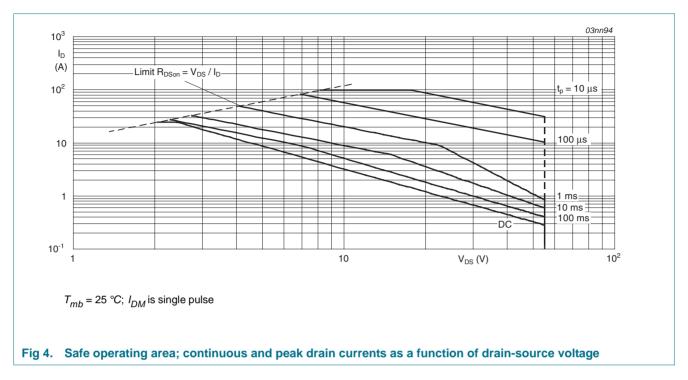
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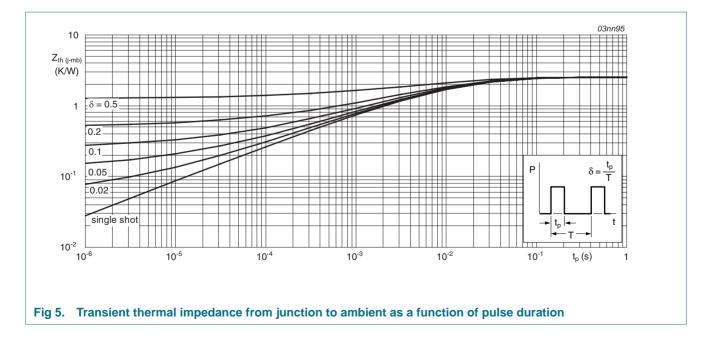
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5. Thermal characteristics

Table 5.Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	see <u>Figure 5</u>	-	-	2.5	K/W

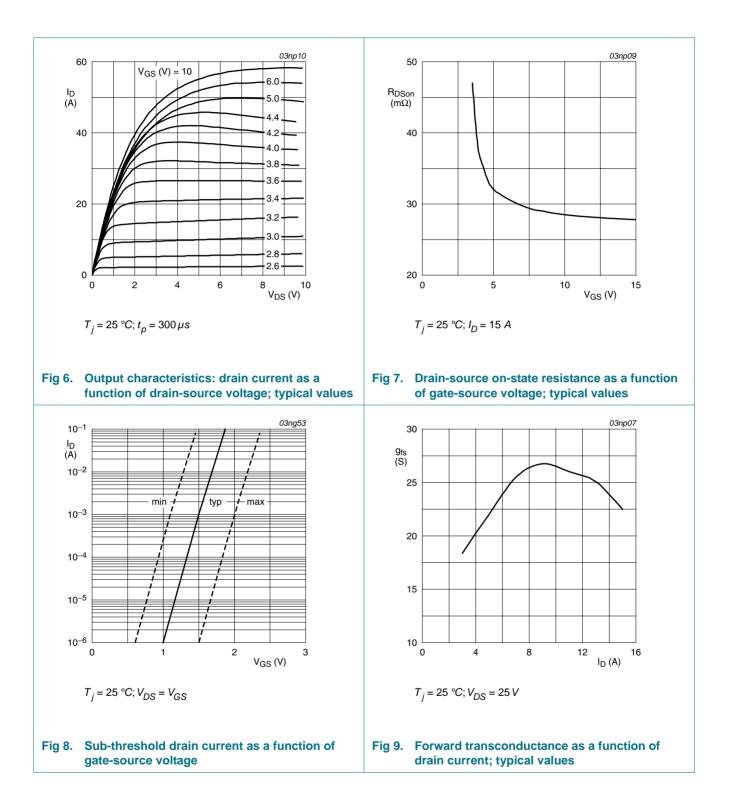


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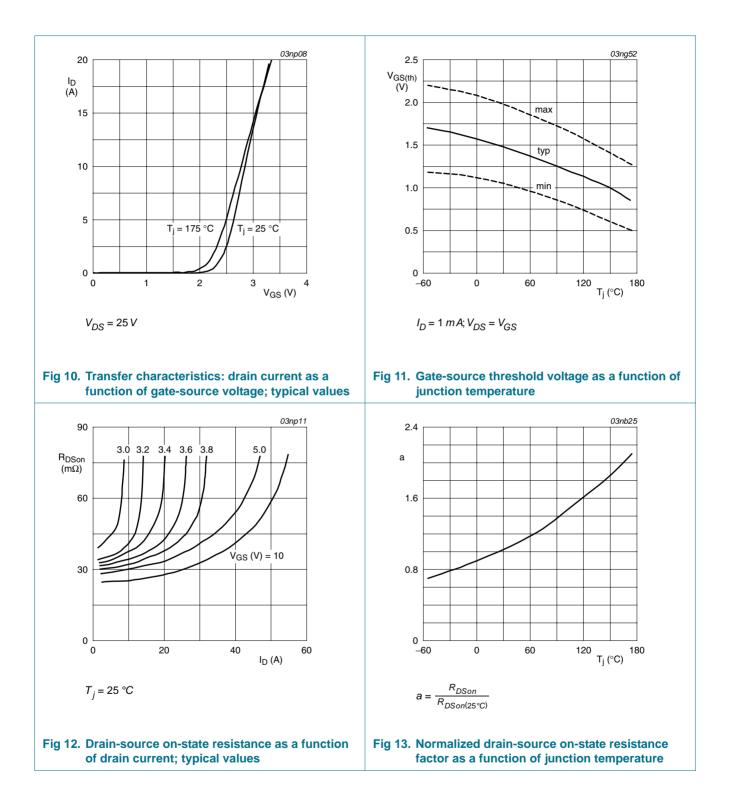
6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _{(BR)DSS}	drain-source breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V};$ $T_j = 25 \text{ °C}$	55	-	-	V
		$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V};$ $T_j = -55 \text{ °C}$	50	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS};$ $T_j = 175 \text{ °C}; \text{ see } Figure 11$	0.5	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see <u>Figure 11</u>	1.1	1.5	2	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS};$ $T_j = -55 \text{ °C}; \text{ see } \frac{\text{Figure } 11}{1}$	-	-	2.3	V
I _{DSS}	drain leakage current	$V_{DS} = 55 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$	-	0.02	1	μA
		V _{DS} = 55 V; V _{GS} = 0 V; T _j = 175 °C	-	-	500	μΑ
I _{GSS}	gate leakage current	V_{DS} = 0 V; V_{GS} = 15 V; T_j = 25 $^\circ C$	-	2	100	nA
		$V_{DS} = 0 V; V_{GS} = -15 V;$ $T_j = 25 °C$	-	2	100	nA
R _{DSon}	drain-source on-state resistance	$V_{GS} = 5 \text{ V}; I_D = 15 \text{ A}; T_j = 175 \text{ °C};$ see <u>Figure 12</u> and <u>13</u>	-	-	84	mΩ
		V_{GS} = 10 V; I_{D} = 15 A; T_{j} = 25 $^{\circ}C$	-	32	36	mΩ
		V_{GS} = 4.5 V; I_{D} = 15 A; T_{j} = 25 $^{\circ}C$	-	-	45	mΩ
		$V_{GS} = 5 \text{ V}; I_D = 15 \text{ A}; T_j = 25 \text{ °C};$ see <u>Figure 12</u> and <u>13</u>	-	34	40	mΩ
Source-d	rain diode					
V _{SD}	source-drain voltage	I _S = 20 A; V _{GS} = 0 V; T _j = 25 °C; see <u>Figure 16</u>	-	0.85	1.2	V
t _{rr}	reverse recovery time	$I_{S} = 20 \text{ A}; \text{ d}I_{S}/\text{d}t = -100 \text{ A}/\mu\text{s};$	-	45	-	ns
Q _r	recovered charge	V _{GS} = -10 V; V _{DS} = 30 V; T _j = 25 °C	-	25	-	nC
Dynamic	characteristics					
Q _{G(tot)}	total gate charge	$I_D = 15 \text{ A}; V_{DS} = 44 \text{ V}; V_{GS} = 5 \text{ V};$	-	11	-	nC
Q _{GS}	gate-source charge	T _j = 25 °C; see <u>Figure 14</u>	-	2	-	nC
Q _{GD}	gate-drain charge		-	5	-	nC
C _{iss}	input capacitance	$V_{GS} = 0 V; V_{DS} = 25 V;$	-	765	1020	pF
C _{oss}	output capacitance	f = 1 MHz; T _j = 25 °C; see Figure 15	-	123	148	pF
C _{rss}	reverse transfer capacitance		-	71	97	pF
t _{d(on)}	turn-on delay time	$V_{DS} = 30 \text{ V}; \text{ R}_{L} = 2.2 \Omega;$	-	17	-	ns
t _r	rise time	V _{GS} = 5 V; R _{G(ext)} = 10 Ω; -T _i = 25 °C	-	93	-	ns
t _{d(off)}	turn-off delay time	·j = 20 0	-	35	-	ns
t _f	fall time		-	72	-	ns

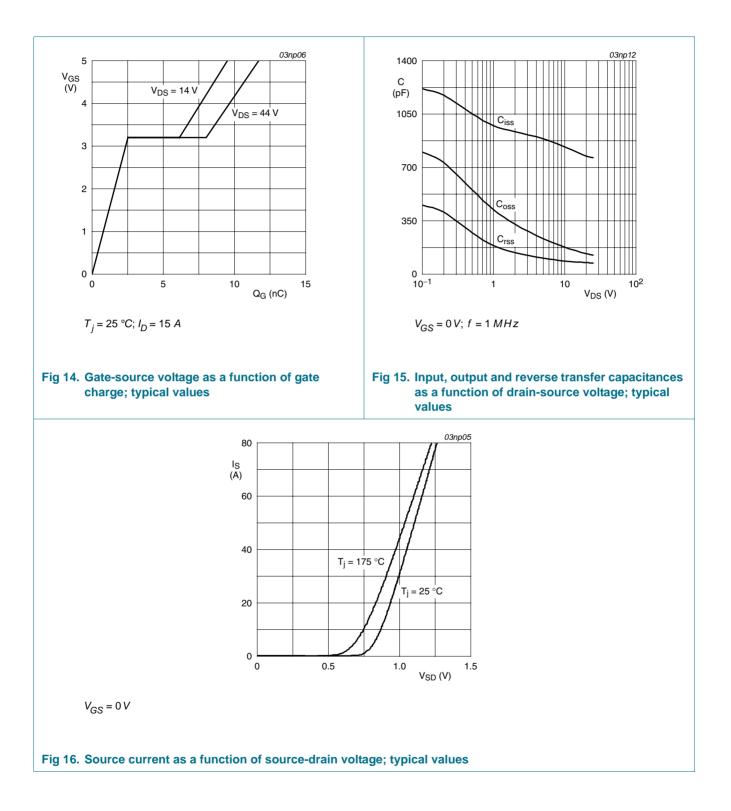
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7. Package outline

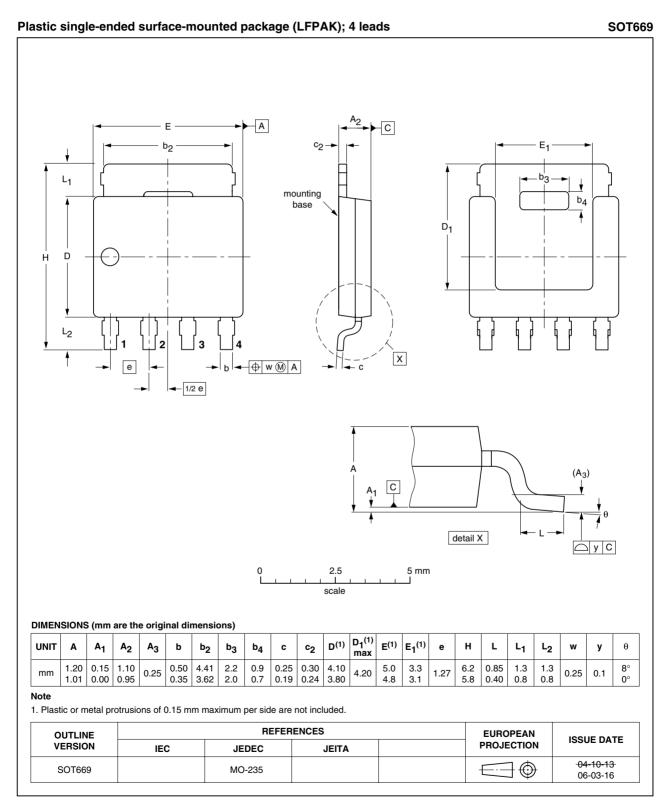


Fig 17. Package outline SOT669 (LFPAK)

8. Revision history

Document IDRelease dateData sheet statusChange noticeSupersedesBUK9Y40-55B_320080222Product data sheet-BUK9Y40-55B_2Modifications:• The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. • Legal texts have been adapted to the new company name where appropriate.BUK9Y40-55B_220060411Product data sheet-BUK9Y40_55B-01BUK9Y40_55B-0120040528Product data sheet	Table 7. Revision h	istory			
Modifications: • The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. • Legal texts have been adapted to the new company name where appropriate. BUK9Y40-55B_2 20060411 Product data sheet - BUK9Y40-55B_2 20060411	Document ID	Release date	Data sheet status	Change notice	Supersedes
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		 Legal texts 	s have been adapted to the r	new company name whe	ere appropriate.
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	BUK9Y40_55B-01	20040528	Product data sheet	-	-

9. Legal information

9.1 Data sheet status

Document status[1][2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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